Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/653,801	JONES ET AL.	
Examiner	Art Unit	
Randall Chin	1744	

SEARCHED					
Class	Subclass	Date	Examiner		
15	106				
15	160	V	\bigvee		
15	172	11/22/2005	RC		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, OCR, DERWENT, EPO, JPO				
Inventor name search	11/22/2005	RC		
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